1. Features

- **1K X 1 Serial EEPROM with Security Logic**
- **Two Application Zones**
- **Stores and Validates Security Codes**
- **Maximum of Four Incorrect Security Code Attempts**
- **Provides Transport Code Security**
- **Low Voltage Operation: 2.7V to 5.5V**
- **Manufactured using Low Power CMOS Technology**
- **V_{PP} Internally Generated**
- **2 µs Read Access Time; 3 ms Write Cycle Time**
- **ESD Protection 4,000V Minimum.**
- **High Reliability:**
    - **100,000 Program/Erase Cycles Guaranteed**
   - **Data Retention of 10 years**

2. Description

The AT88SC102 device is a low-cost, synchronous, secure memory integrated circuit, designed for use in prepaid and loyalty smart card applications. The AT88SC102 provides 1024 bits of serial Electrically Erasable and Programmable Read Only Memory (EEPROM) within two Application Zones, plus 64 bits in a code protected zone. Additional EEPROM memory and security logic provide security for smart card applications. Space is provided in the EEPROM memory for manufacturing records for both the smart card manufacturer and card issuer. After personalization, these records, and the state of the bit which enables the Erase Counter function, are locked and protected from modification for the lifetime of the product.

Table 2-1. Pin Configuration

ISO Contact	Pad Name	Description
C1	VCC	Operating Voltage
C2	RST	Address Reset
C3	CLK	Clock and Address Control
C4	FUS	Fuse
C5	GND	Ground
C6	NC	No Connect
C7	I/O	Bidirectional Data
C8	PGM	Programming Control

Figure 2-1. Card Module Contact

V_{CC} = C1
RST = C2
CLK = C3
FUS = C4
C5 = GND
C6 = NC
C7 = I/O
C8 = PGM
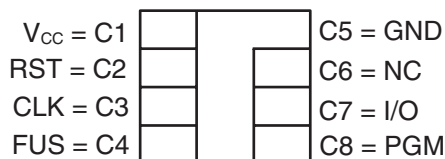
1K EEPROM–Security Logic with Two Application Zones

AT88SC102

3. Terminology

The following terms have specific definitions for the AT88SC102.

3.1 Erase

Erase is a program operation that results in an EEPROM data bit being set to a logic "1" state. Outside the application zones, all erase operations are performed on 16-bit words. An erase operation performed on any bit within a word will execute an erase of the entire word. Inside the application zones, erase operations are controlled by the SV flag, EZ passwords, and EC2EN fuse. These operations are defined in the "Device Operation" section of the data sheet.

3.2 Write

Write is a program operation that results in an EEPROM bit or word being set to a logic "0" state. An unwritten bit is defined as erased or set to a logic "1" state. Write operations in the AT88SC102 may be performed on individual bits after security code validation. In Security Level 2, write operations also require that the P1 or P2 bit within the application zone is set to "1".

3.3 Program

Program is an EEPROM function that activates internally timed, high-voltage circuitry and results in a data bit or word being set to either a logic "0" or "1" state.

3.4 Bit

A *bit* is a single data element set to either a logic "0" or "1" state. All bit addresses within the application zones (AZ1, AZ2) may be written individually.

3.5 Byte

A *byte* is eight consecutive data bits. A byte boundary will begin on an address that is evenly divisible by eight. The AT88SC102 has no capability for byte write operations.

3.6 Word

A *word* is sixteen consecutive data bits. A word boundary will begin on an address that is evenly divisible by 16. Erase operations will always operate on 16-bit words when applied to addresses outside the application zones. In Security Level 1, erase operations within the application zones also operate on 16-bit words. In Security Level 2, erase operations within the application zones operate on the entire zone. Write operations function on single bits, not words, in both security levels.

3.7 Blown

In reference to an AT88SC102 internal EEPROM fuse, the blown state is a logic "0".

3.8 Unblown

In reference to an AT88SC102 internal EEPROM fuse, the unblown state is a logic "1".

3.9 Verification

AT88SC102 operations are controlled by the state of several internal flags. The flags SV, E1, and E2 are set after verification of an associated password (security code or EZ1 or EZ2 respectively). Verification is accomplished by executing an INC/CMP operation, which correctly

matches the password bit by bit as the CLK increments the address through the password memory addresses.

Figure 3-1. Block Diagram
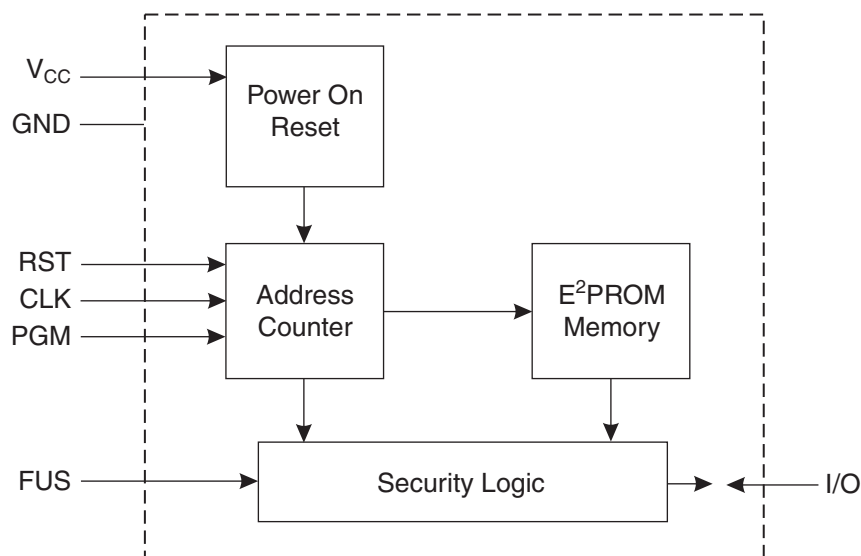
The AT88SC102 is manufactured using low-power CMOS technology and features its own internal high-voltage pump for single voltage supply operation. The devices are guaranteed to 100,000 erase/write cycles and 10-year data retention. The AT88SC102 supports the ISO/IEC 7816-3 synchronous protocol.

4. Security Features

The security features of Atmel's AT88SC102 include:

- Data access only after validation of the security code.
- Permanent invalidation of the device after four consecutive false security code presentations.
- Read/write protection of certain memory zones.
- Secure transport of devices using transport code compare sequence.
- Unique customer identification number written and locked into every device for protection against duplication or counterfeiting.

4.1 Security Levels and Memory Access to AT88SC102

Access to the memory is controlled by the state of the issuer fuse and by the voltage supply applied on the FUS pad.

Table 1.

FUS Pad	Issuer Fuse	Security Level
Logic "0"	X	2
Logic "1"	1	1
Logic "1"	0	2

4.1.1 Level 1: Security During Personalization

AT88SC1003 die and modules are delivered with the issuer fuse intact. Issuer personalization is completed at this level. Security code validation is required to allow access to personalize the EEPROM memory. During personalization, the manufacturer fuse may be blown to lock the manufacturer's zone.

See "Memory Access Rules During Personalization" (Table 9-1 on page 10).

Conditions:

Issuer fuse = "1" (not blown)

FUS pin = "1" (required)

4.1.2 Level 2: Security After Personalization

EEPROM memory zones are protected by the various flags and passwords. After issuer personalization, Security Level 2 is implemented by blowing the issuer fuse. The device can also be placed in Security Level 2 by taking the FUS pin low, independent of the state of the issuer fuse. This function of the FUS pin enables the card issuer to simulate Security Level 2 during application development without permanently blowing the issuer fuse.

See "Memory Access Rules After Personalization" (Table 10-1 on page 11).

Conditions:

Issuer fuse = "0" (blown)

FUS pin = "X"

or

Issuer fuse = "1" (not blown)

FUS pin = "0"

5. Memory Map

Table 5-1. AT88SC102 Memory Diagram

Bit Address	Description	Bits	Words
0–15	Fabrication Zone (FZ)	16	1
16–79	Issuer Zone (IZ)	64	4
80–95	Security Code (SC)	16	1
96–111	Security Code Attempts counter (SCAC)	16	1
112–175	Code Protected Zone (CPZ)	64	4
176–687	Application Zone 1 (AZ1)	512	32
688–735	Application Zone 1 Erase Key (EZ1)	48	3
736–1247	Application Zone 2 (AZ2)	512	32
1248–1279	Application Zone 2 Erase Key (EZ2)	32	2
1280–1407	Application Zone 2 Erase Counter (EC2)	128	8
1408–1423	Memory Test Zone (MTZ)	16	1
1424–1439	Manufacturer's Zone (MFZ)	16	1
1440–1455	Block Write/Erase	16	1
1456–1471	MANUFACTURER'S FUSE	16	1
1529	EC2EN FUSE (Controls use of EC2)	1	
1552 - 1567	ISSUER FUSE	16	1

6. Memory Zones

Table 6-1. Memory Zones

Zone	Definition
Fabrication Zone **FZ** (16 bits)	The 16-bit fabrication zone is programmed when the chip is manufactured and cannot be changed. Application software may check this fabrication zone code to assure that the device was manufactured by Atmel.
Issuer Zone **IZ** (64 bits)	The 64-bit issuer zone is programmed by the card issuer during the personalization phase. It will contain issuer-specific information, such as serial numbers and dates. This area becomes read-only after the issuer fuse has been blown. Read access is always allowed in the issuer zone.
Security Code **SC** (16 bits)	The card security code is initially set by Atmel to protect the card during transportation to the card issuer. During personalization, this code must be verified by the AT88SC102 to allow access to the EEPROM memory. After the security code has been verified, the code itself may be changed in either security mode. While in personalization mode (Security Level 1), the security code gives erase and write access to both the application zones and the code protected zone. In Security Level 2, the security code gives write access to both the application zones and the code protected zone. Erase access requires verification of both the security code and the erase key (EZ1 or EZ2). Verification of the security code will set the internal flag SV to "1". Atmel ships the device with a security code (transportation code) pre-programmed. This protects against the unauthorized use of an unpersonalized device and should be written to a new value during initialization.

6. Memory Zones

Table 6-1. Memory Zones

Zone	Definition
Security Code Attempts Counter **SCAC** (16 bits)	The protocol for verification of the security code requires that the user write one of the first four bits of the SCAC to a logic "0". This allows the SCAC to count the number of consecutive incorrect presentations of the security code. After four consecutive incorrect security code presentations, the first four bits of the SCAC will all be written to "0", and the user is permanently blocked from access to the application zones, as well as other areas controlled by the security code. After a successful presentation of the security code, the entire 16-bit SCAC, including the four active bits, should be erased. This verifies that the correct security code has been presented, since an erase operation in this area is not allowed without SC verification. It also clears the SCAC bits in preparation for the next use of the card. This erase operation will also clear the remaining twelve bits of the 16-bit SCAC word. These twelve bits may be used in an application, although the entire 16-bit word will be erased if any bit in the SCAC is erased.
Code Protected Zone **CPZ** (64 bits)	Read access to this area is always allowed and does not require SC validation. The security code must be correctly presented to allow write or erase access to the code protected zone.
Application Zones 1 and 2 **AZ1 and AZ2** (512 bits each)	The application zones (AZ1 and AZ2) are intended to hold user application data. P1 (address 176) controls write access, and R1 (address 177) controls read access within AZ1. P2 (address 736) controls write access and R2 (address 737) controls read access within AZ2. In Security Level 1, an entire 16-bit word will be erased if an erase is performed on any single bit within that word. In Security Level 2, erase operations are controlled by both the SV flag and the erase keys (EZ1 and EZ2). See the Device Operation ERASE definition for specific details. The number of erase operations performed in AZ2 may be limited by leaving the EC2EN fuse set to "1". The AT88SC102 allows unlimited erase operations of AZ1.
Application Zone Erase Keys **EZ1** (48 bits) **EZ2** (32 bits)	(Enabled in Security Level 2 only) The erase keys are passwords used to control erase operations within the application zones, after the issuer fuse has been blown (Security Level 2). The erase key passwords are written by the issuer during personalization (Security Level 1), after verification of the security code. EZ1 and EZ2 can not be changed after the issuer fuse is blown. In Security Level 2, the AT88SC102 allows only block erasure of an entire application zone. AZ1 can be erased only after both the SC and the EZ1 password have been validated. Verification of EZ1 will set the internal flag E1 to "1". AZ2 can be erased only after both the SC and the EZ2 password have been validated. Verification of EZ1 will set the internal flag E1 to "1". Verification of EZ2 will set the internal flag E2 to "1".
Application Zone 2 Erase Counter **EC2** (128 bits)	(Enabled in Security Level 2 only) The Application Zone 2 Erase Counter (EC2) is enabled only in Security Mode 2 and only when the EC2EN fuse is set to "1". If both of these conditions are true, the user will be limited to 128 erase operations in Application Zone 2. EC2 is used to count these erase cycles. The erase protocol for the AT88SC102 Application Zone 2 requires one bit in EC2 to be written to "0". After 128 erase operations, all 128 bits in EC2 will be "0" and the user will be blocked from erasing AZ2. The erase counter is only writeable and cannot be erased. When the EC2EN fuse = "0", the EC2 operation is disabled. In that case there is no limit to the number of times AZ2 can be erased, and EC2 has no function.
Memory Test Zone **MTZ** (16 bits)	All operations are allowed for this zone (write, erase, read). The purpose of this zone is to provide an area in the product memory which is not restricted by security logic. It is used for testing purposes during the manufacturing process, and may also be used in the product application if desired, although no security protection exists for the MTZ.
Manufacturer's Zone **MFZ** (16 bits)	The MFZ is intended to hold data specific to the smart card manufacturer (like assembly lot codes, dates, etc.). Read operations within this zone are always allowed. Write or erase operations within this zone are allowed after the SC has been verified. After the data is entered by the card manufacturer, the manufacturer's fuse can be blown and the data within the MFZ will become read-only. Blowing the issuer fuse will also lock the data in the MFZ.

6. Memory Zones

Table 6-1. Memory Zones

Zone	Definition
EC2EN Fuse (1 bit)	This single-bit EEPROM fuse selects whether the EC2 counter is used to limit the number of AZ2 erase operations in Security Mode 2. If the EC2EN fuse is unblown ("1"), the number of erase operations allowed in AZ2 is limited to 128. If the EC2EN fuse is blown ("0"), there is no limit to the number of erase operations in AZ2. After the issuer fuse is blown, the state of the EC2EN fuse is locked and cannot be changed.
Issuer Fuse (16 bits)	This EEPROM fuse is used to change the security mode of the AT88SC102 from Security Mode 1 ("1") to Security Mode 2 ("0"). Initialization of the AT88SC102 for use by the end customer occurs in Security Mode 1. Access conditions in Security Mode 1 are described in Table 1. Access conditions in Security Mode 2 are described in Table 2.
Manufacturer's Fuse (1 bit)	This single-bit EEPROM fuse is used to lock the data stored in the manufacturer's zone after personalization has been completed.

6.1 Internal Flags

Table 6-2. Definition of AT88SC102 Internal Flags

Zone	Definition	Operation	Function
SV	Security Validation Flag	The SV flag is set by correctly matching the 16-bit security code bit-by-bit from address 80 through 95 as CLK increments the address counter. The security code matching operation must be followed immediately by a validation operation within the Security Code Attempts Counter (SCAC). This validation operation requires the user to find a bit in the first eight bits of the SCAC (addresses 96–103) that is a logic "1". A write operation is performed, followed by an erase. The AT88SC102 will validate that the comparison was correct by outputting a logic "1", and SV will be set. After the erase, all 16 bits in the SCAC will also be erased. The SV flag remains set until power to the card is turned off. If the comparison was in error, or part of the validation was not performed correctly, the AT88SC102 will output a logic "0", showing that the SV flag has not been set. After eight consecutive incorrect security code presentations, the card is permanently locked.	This flag is the master protection for the memory zones. See Tables 1 and 2.
P1	Application Zone 1 Write Flag	If Bit 176 has been programmed to a logic "1", this flag is set after Bit 176 has been addressed. The flag remains set until power to the device is turned off, even if this bit is written to "0" by a subsequent operation.	P1 and SV must both be set in order to enable a write command in the application zone (Security Mode 2).
R1	Application Zone 1 Read Flag	If Bit 177 has been programmed to a logic "1", this flag is set after Bit 177 has been addressed. The flag remains set until power to the device is turned off, even if this bit is written to "0" by a subsequent operation.	R1 or SV must be set in order to enable Application Zone 1 to be read.
P2	Application Zone 2 Write Flag	If Bit 736 has been programmed to a logic "1", this flag is set after Bit 736 has been addressed. The flag remains set until power to the device is turned off, even if this bit is written to "0" by a subsequent operation.	P2 and SV must both be set in order to enable a write command in Application Zone 2 (Security Mode 2).
R2	Application Zone 2 Read Flag	If Bit 737 has been programmed to a logic "1", this flag is set after Bit 737 has been addressed. The flag remains set until power to the device is turned off, even if this bit is written to "0" by a subsequent operation.	R2 or SV must be set in order to enable Application Zone 2 to be read.

Table 6-2. Definition of AT88SC102 Internal Flags (Continued)

Zone	Definition	Operation	Function
E1	Application Zone 1 Erase Flag	The E1 flag is set by correctly matching the Application Zone 1 Erase Key (EZ1) bit by bit as pin CLK increments the address counter. To complete an erase operation of AZ1 in Security Level 2, an erase operation must be performed on Bit 736 after E1 is set. The E1 flag is reset when the address counter = 0.	Application Zone 1 (Bits 176–687) will be erased when E1 is set and an erase is performed on Bit 736. This operation erases all bits in Application Zone 1. There is no limit to the number of erase operations that can be performed on AZ1.
E2 EC Enabled	Application Zone 2 Erase Flag with Erase Counter operation enabled. (EC2EN FUSE = "1")	This flag is set by correctly matching the Application Zone 2 Erase Key (EZ2) bit by bit as pin CLK increments the address counter. Then a validation operation must be completed. This operation requires the user to find a bit in Application Zone 2 Erase Counter (EC2), addresses 1280–1407, that is a logic "1". A write must then be performed, followed by an erase. The AT88SC102 will validate that the comparison was correct and Application Zone 2 will be erased. This flag is also reset when the address counter = 0.	Application Zone 2 (Bits 736–1237) is erased when E2 is set and an erase is performed after the validation operation in EC2 described above. This operation erases all bits in Application Zone 2.
E2 EC Disabled	Application Zone 2 Erase Flag with Erase Counter operation disabled. (EC2EN FUSE = "0")	E2 is set when the Application Zone 2 Erase Key comparison is valid. It is reset when the address counter = 0.	Application Zone 2 (bits 736–1247) is erased when E2 is set and an erase is performed on Bit 1280. This operation erases all bits in Application Zone 2 but does not affect the word containing Bit 1280.

7. Definition of AT88SC102 Passwords

Table 7-1. Definition of Passwords

Table 1.

Password	Definition
Security Code (**SC**) Bits 80–95 (16 bits)	This password is used to set the Security Validation (SV) flag and is used in determining what operations are allowed in each zone (see Tables 1 and 2).
Application Zone 1 Erase Key (**EZ1**) Bits 688–735 (48 bits)	This password must be programmed during issuer personalization. It is used to erase Application Zone 1 in Security Level 2. Verification of EZ1 will set the internal flag E1 to "1".
Application Zone 2 Erase Key (**EZ2**) Bits 1248–1279 (32 bits)	This password must be programmed during issuer personalization. It is used to erase Application Zone 2 in Security Level 2. Verification of EZ2 will set the internal flag E2 to "1".

8. Definition of AT88SC102 Fuses

- **Manufacturer Fuse**

This fuse is used to control writes and erases of the Manufacturer Zone (MFZ). When the security code has been validated and both the issuer fuse and the manufacturer fuse are unblown, writes and erases of the MFZ are allowed. Blowing the issuer fuse will also disable the manufacturer fuse if it has not been blown previously.

- **EC2EN Fuse**

This fuse selects whether the EC2 counter is used to limit the number of Application Zone 2 erases allowed in Security Mode 2. If the EC2EN fuse is "unblown", then the Application Zone 2 erases are limited to 128. If the EC2EN fuse is "blown", the application zone erases are unlimited. After the issuer fuse is blown, the state of the EC2EN fuse is locked and cannot be changed.

- **Issuer Fuse**

This fuse is used to personalize the AT88SC102 for end use. It is an additional EEPROM bit that can be programmed to a logic "0". This is its "blown" state. Security of the device when the issuer fuse is a logic "1" is described in Table 1. The device is in Security Level 2 when the issuer fuse is blown. The device can also be placed in Security Level 2 by taking the FUS pin low independent of the state of issuer fuse. Memory access rules of the device in Security Level 2 are described in Table 2.

9. Memory Access Rules During Personalization – Security Mode 1[1]

Table 9-1. Access Conditions During Personalization (issuer fuse not blown)

Zone	SV[2]	R1[3]	R2[4]	MF[5]	Read	Erase	Write	Compare
FZ	x	x	x	x	yes	no	no	no
IZ	0	x	x	x	yes	no	no	no
	1	x	x	x	yes	yes	yes	no
SC	0	x	x	x	no	no	no	yes
	1	x	x	x	yes	yes	yes	no
SCAC	0	x	x	x	yes	no	yes	no
	1	x	x	x	yes	yes	yes	no
CPZ	0	x	x	x	yes	no	no	no
	1	x	x	x	yes	yes	yes	no
AZ1	0	0	x	x	no	no	no	no
	0	1	x	x	yes	no	no	no
	1	x	x	x	yes	yes	yes	no
EZ1	0	x	x	x	no	no	no	no
	1	x	x	x	yes	yes	yes	no
AZ2	0	x	0	x	no	no	no	no
	0	x	1	x	yes	no	no	no
	1	x	x	x	yes	yes	yes	no
EZ2	0	x	x	x	no	no	no	no
	1	x	x	x	yes	yes	yes	no
EC2	0	x	x	x	yes	no	yes	no
	1	x	x	x	yes	yes	yes	no
MTZ	x	x	x	x	yes	yes	yes	no
MFZ	0	x	x	x	yes	no	no	no
	1	x	x	0	yes	no	no	no
	1	x	x	1	yes	yes	yes	no

Notes: 1. Security Mode 1 Conditions:
   EC2EN = "1" or "0"
   Issuer Fuse = "1"
   FUS Pin = "1" (required)

2. SV = "1" after validation of the security code

3. R1: 2nd bit of Application Zone 1 (Bit 177)

4. R2: 2nd bit of Application Zone 2 (Bit 737)

5. MF: Manufacturers Fuse = "0" when blown

10. Memory Access Rules After Personalization – Security Mode 2[1]

Table 10-1.   Access Conditions After Personalization (issuer fuse blown)

Zone	SV[2]	P1[3]	R1[4]	P2[5]	R2[6]	E1[7]	E2[8]	Read	Erase	Write	Compare
FZ	x	x	x	x	x	x	x	yes	no	no	no
IZ	x	x	x	x	x	x	x	yes	no	no	no
SC	0	x	x	x	x	x	x	no	no	no	yes
	1	x	x	x	x	x	x	no	yes	yes	no
SCAC	0	x	x	x	x	x	x	yes	no	yes	no
	1	x	x	x	x	x	x	yes	yes	yes	no
CPZ	0	x	x	x	x	x	x	yes	no	no	no
	1	x	x	x	x	x	x	yes	yes	yes	no
AZ1	0	x	0	x	x	x	x	no	no	no	no
	0	x	1	x	x	x	x	yes	no	no	no
	1	0	x	x	x	0	x	yes	no	no	no
	1	0	x	x	x	1	x	yes	yes	no	no
	1	1	x	x	x	0	x	yes	no	yes	no
	1	1	x	x	x	1	x	yes	yes	yes	no
EZ1	x	x	x	x	x	x	x	no	no	no	yes
AZ2	0	x	x	x	0	x	x	no	no	no	no
	0	x	x	x	1	x	x	yes	no	no	no
	1	x	x	0	x	x	0	yes	no	no	no
	1	x	x	0	x	x	1	yes	yes	no	no
	1	x	x	1	x	x	0	yes	no	yes	no
	1	x	x	1	x	x	1	yes	yes	yes	no
EZ2	x	x	x	x	x	x	x	no	no	no	yes
EC2	x	x	x	x	x	x	x	yes	no	yes	no
MTZ	x	x	x	x	x	x	x	yes	yes	yes	no
MFZ	x	x	x	x	x	x	x	yes	no	no	no

Notes: 1. Security Mode 2 Conditions:
Manufacturer Fuse = "X"
EC2EN Fuse = "1" or "0"
Issuer Fuse = "0"
FUS Pin = "X"

2. SV = "1" after validation of the security code

3. P1: 1st bit of Application Zone 1 (Bit 176)

4. R1: 2nd bit of Application Zone 1 (Bit 177)

5. P2: 1st bit of the Application Zone (Bit 736)

6. R2: 2nd bit of the Application Zone 2 (Bit 737)

7. E1 = "1" after a valid presentation of the Application Zone 1 Erase Key (EZ1)

8. E2 = "1" after a valid presentation of the Application Zone 2 Erase Key (EZ2)

11. Micro Operations

The AT88SC102 circuit operation modes are selected by the input logic levels on the control pins PGM, CLK, and RST and by the internal address. Timing for these operations is specified in the AC Characteristics section.

Table 11-1. Micro Operations

Operation	PGM	RST	CLK	Definition
RESET	X	⌐_	0	This operation will reset the internal address to "0". After the falling edge of RST, the first bit of the fabrication zone (Address 0) will be driven on the I/O contact. The erase flags (E1 and E2) will be reset.
INC/READ	0	0	⌐_⌐	The address is incremented on the falling edge of CLK. If read operations are enabled, the addressed bit will be driven on the I/O pin after the falling edge of CLK. When read operations are disabled, the I/O will be disabled and pulled to a high state by the external system pull-up resistor.
INC/CMP	0	0	⌐_⌐	The INC/CMP operation will compare the value of the data driven by the system host on the I/O pin to the value of the bit already written into the EEPROM memory at that address location. This process is used during validation of the AT88SC102 security code and erase keys. The data must be stable on the I/O pin before the rising edge of CLK when the data will be latched internally. Comparison occurs on the next falling edge of CLK. The internal address is also incremented on the falling edge of CLK.
ERASE/WRITE	1	0	_⌐_	The I/O pin must be driven to a "1" for an erase and to a "0" for a write operation before the rising edge of CLK (see t_{DS})
STANDBY	0	1	X	The device is placed in standby mode when FUS pin = "0" and RST = "1". The address will not increment when RST is high.

Notes: 1. The output is disabled (hi-state) on all addresses where the read operation is disabled.

2. The two instructions INC/READ and INC/CMP share the same control signal states.

3. The circuit will distinguish between the INC/READ and INC/CMP instructions by testing the internal address counter. (CMP can only be done with the addresses corresponding to the security code or to an erase key).

4. The internal address counter counts up to 1567. An additional CLK pulse resets the address to "0".

12. Device Functional Operation

Table 12-1. Device Functional Operation

Name	Functional Operation Sequence
POR	OPERATION: POR (power-on reset) is initiated as the device power supply ramps from 0V up to a valid operating voltage. FUNCTION: POR resets all flags, and the address is reset to "0".
RESET	OPERATION: With CLK low, a falling edge on the RST pin will reset the address counter to address "0". FUNCTION: The address is reset to "0", and the first bit of the memory is driven by the AT88SC102 on I/O after a reset. Only E1 and E2 are reset when the address is reset to 0. The Reset operation has no affect on any of the other flags (SV, P1, R1, P2, R2).
ADDRESSING	OPERATION: Addressing is handled by an internal address counter. The address is incremented on the falling edge of CLK. Reset must be low while incrementing the address. A falling edge of reset clears the counter to address "0". FUNCTION: Addressing of the AT88SC102 is sequential. Specific bit addresses may be reached by completing a reset, then clocking the device (INC/READ) until the desired address is reached. The AT88SC102 will determine which operations are allowed at specific address locations. These operations are specified in Tables 1 and 2. For instance, to address the issuer zone (IZ), execute a reset operation, then clock the device 16 times. The device now outputs the first bit of the IZ. After the address counter counts up to 1567, the next CLK pulse resets the address to "0".
READ	OPERATION: RST and PGM pins must be low. If a read operation is allowed, the state of the memory bit being addressed is output on the I/O pin. The I/O buffer is an open drain, and the output of a logic "0" therefore causes the device to pull the pin to ground. The output of a logic "1" causes the device to place the pin in a high impedance state. So to sense a logic "1", an external pull-up must be placed between the I/O pin and VCC. The address counter is incremented on the falling edge of CLK. FUNCTION: **Non-application Zones:** As the address counter is incremented, the contents of the memory are read out on the I/O pin. The read operation is inhibited for addresses where security prevents a read operation (see Tables 1 and 2). **Application Zones:** Application Zone 1 can be read when: SV = "1" or R1 = "1". Application Zone 2 can be read when: SV = "1" or R2 = "1".

Table 12-1. Device Functional Operation (Continued)

Name	Functional Operation Sequence
WRITE	A WRITE operation sets the bit(s) to a logic "0" OPERATION: CLK = "0" PGM "0" → "1" (I/O switches to an input) I/O = "0" (input = "0" for write operation) CLK "0"→ "1" (rising edge of CLK starts the write operation) PGM "1"→ "0" I/O "0"→ "Z" (high-impedance) Wait t_{CHP} (see "AC Electrical Characteristics") CLK "1"→ "0" (falling edge of CLK ends the WRITE operation) Note: The falling edge of CLK that ends the write operation does not increment the address counter. FUNCTION: Non-application Zones: The write operation is inhibited for addresses where security prevents a write operation (see Tables 1 and 2). Application Zones: The Application Zones can be written when: Security Level 1: SV = "1" Security Level 2: SV = "1"and P1 = "1" for AZ1. SV = "1" and P2 = "1" for AZ2
ERASE Operation Sequence	CLK = "0" PGM "0" → "1" (I/O switches to an input) I/O = "1" (input = "1" for erase operation) CLK "0" → "1" (rising edge of CLK starts the erase operation) PGM "1" → "0" I/O "1" → "Z" (high-impedance) Wait t_{CHP} (see "AC Electrical Characteristics") CLK "1" → "0" (falling edge of CLK ends the erase operation) Note: The falling edge of CLK that ends the erase operation does not increment the address counter.
ERASE (Non-Application Zones)	An erase operation sets the bits to logic "1". The EEPROM memory is organized into 16 bit words. Although erases are performed on single bits, the erase operation clears an entire word in the memory (except for the application zones in Security Level 2). Therefore, performing an erase on any bit in the word will clear *all* 16 bits of that word to logic "1". OPERATION: Perform "Erase Operation Sequence" as specified above. FUNCTION: The erase operation is inhibited for addresses where security prevents an erase operation (see Tables 1 and 2.)
ERASE (Application Zones) Security Level 1	Security level 1: (Issuer Fuse = "1" and FUS pin = "0") The Application Zone can only be erased when SV = "1". OPERATION: Increment address counter to any bit within AZ1 or AZ2. Perform "Erase Operation Sequence" as specified above. FUNCTION: This operation will erase the entire 16-bit word containing the bit.

Table 12-1. Device Functional Operation (Continued)

Name	Functional Operation Sequence
ERASE (Application Zone 2) Security Level 2 EC Mode Enabled	Security level 2: (Issuer Fuse = "0" or FUS pin = "0") EC mode is enabled. Erase operations within AZ2 are limited to 128. Application Zone 1 can only be erased when SV = "1" and E1 = "1". OPERATION: Set SV = "1" by validating the security code (see definition of SV internal flag). Increment address counter to the first bit of the Application Zone 2 Erase Key (EZ2 = bit 1248). Execute 32 INC/CMP operations, correctly verifying each bit of the 32-bit erase key. Increment the address counter through the Application Zone 2 Erase Counter (EC2 = bits 1280–1407) until a bit is found that is set to "1". Perform a write operation on this bit (this write will not increment the address counter). Perform an erase operation on the same bit. FUNCTION: This operation will erase the entire Application Zone. One additional bit of Erase Counter 2 will now be written to "0". The erase operation in EC2 will initiate the AZ2 erase, but will not affect the state of the bits within EC2.
ERASE (Application Zone 1 or 2) Security Level 2 EC Mode Disabled	Security Level 2: (Issuer Fuse = "0" or FUS pin = "0") EC mode is disabled in AZ2. Unlimited erase operations in AZ2. AZ1 always allows unlimited erase operations. Application Zone 1 can only be erased when SV = "1" and E1 = "1". Application Zone 2 can only be erased when SV = "1" and E2 = "1". OPERATION: Set SV = "1" by validating the security code (see definition of SV internal flag). Increment address counter to the first bit of the Application Zone Erase Key (EZ1 = bit 688, EZ2 = bit 1248). Execute 32 or 48 INC/CMP operations, correctly verifying each bit of the 32- or 48-bit erase key. Increment the address counter to the next bit (bit 736, to erase AZ1, bit 1280 to erase AZ2). Perform an erase operation on this bit. FUNCTION: This operation will erase the entire Application Zone but does not affect the word containing bit 736 or 1280.
Block Write/Erase	Enabled in Security Level 1 only. OPERATION: Set address counter between address 1440 and 1455. SV must be set. FUS pin must be high. Perform a write or erase operation. FUNCTION: The entire memory excluding the Fabrication Zone (FZ), Memory Test Zone (MTZ) and Manufacturer's Zone (MFZ) will be written to "0" (write) or "1" (erase). The block write/erase modes are used to quickly personalize the device.

Table 12-1. Device Functional Operation (Continued)

Name	Functional Operation Sequence
Blowing Manufacturer Fuse	Valid in Security Level 1. OPERATION: Set address counter between address 1456 and 1471. SV must be set. The FUS pin can be either a "0" or a "1". RST pin = "1" Perform a write operation. FUNCTION: The manufacturer fuse will be at a logic "0" state. Note: The address will not change as long as RST is high. CLK should be low when RST is brought low. This will reset the address counter to "0".
Blowing EC2EN Fuse	Valid in Security Level 1. The EC2EN fuse must be blown before the issuer fuse is blown. OPERATION: Set the address counter to address 1529. FUS pin = "1" RST pin = "1" Perform a write operation. FUNCTION: EC2EN fuse will be written to a logic "0" state. Note: The address will not change as long as RST is high. CLK should be low when RST is brought low This will reset the address counter to "0".
Blowing Issuer Fuse	OPERATION: Set address counter between address 1552 and 1567. SV must be set. The FUS pin can be either a "0" or a "1". RST pin = "1" Perform a write operation. FUNCTION: The issuer fuse will be set to a logic "0" state. This operation will convert the AT88SC102 from Security Level 1 to Security Level 2. The action is irreversible. Note: The address will not change as long as RST is high. CLK should be low when RST is brought low. This will reset the address counter to 0.

Table 12-2. Function of FUS and RST Pin

FUS	Used for personalizing the device. FUS must be high to be able to personalize the device when the issuer fuse is unblown. In Security Level 1, the FUS pin may be forced low to simulate Security Level 2. In Security Level 2, the FUS pin has no function.
RST	This pin is used to reset the address counter address to 0. It is also used in writing the issuer fuse and the EC2EN FUSE low. When the FUS pin is low and the RST pin is high, the part is in stand-by mode.

13. Absolute Maximum Ratings

Operating Temperature .... 0°C to +70°C	
Storage Temperature............................ -65°C to +150°C	
Voltage on Any Pin with Respect to Ground.................... -0.3V to V_{CC} + 0.7V	
Maximum Voltage.. 6.25V	
DC Output Current... 5.0 mA	

Note: Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions beyond those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

14. DC Characteristics

Applicable over recommended operating range from: V_{CC} = 2.7V to 5.5V and T_{AC} = 0°C to +70°C (unless otherwise noted).

Table 14-1.   DC Characteristics

Symbol	Characteristics	Min	Type	Max	Unit
I_{CC}	Supply Current on V_{CC} during Read (T_{AMB} = + 25°C)			2	mA
I_{CCP}	Supply Current on V_{CC} during Program (T_{AMB} = + 25°C)			5	mA
I_{SB}	Standby Current on VCC (RST @ V_{CC}; FUS, CLK, PGM @ GND; I_{OL} = 0 µA; F_{CLK} = 0 kHz)			50	µA
V_{IL}	Input Low Level	−0.3		V_{CC} x 0.3	V
V_{IH}	Input High Level	V_{CC} x 0.7		V_{CC} + 0.3	V
V_{OL}	Output Low Level (I_{OL} = 1mA)			0.4	V
I_{IL}	Input Leakage Current			20	µA
I_{IH}	I/O Leakage Current (V_{OH} = V_{CC} Open Drain)			20	µA

15. AC Characteristics

Table 15-1. AC Characteristics

T_{AC} = 0°C to +70°C, V_{CC} = 5V ± 10%, GND = 0V (unless otherwise noted).

Symbol	Characteristics	Min	Type	Max	Unit
t_{CLK}	Clock Cycle Time	3.3			µs
t_{RH}	RST Hold Time	0.1			µs
t_{DVR}	Data Valid Reset to Address "0"			2.0	µs
t_{CH}	CLK Pulse Width (High)	0.2			µs
t_{CL}	CLK Pulse Width (Low)	0.2			µs
t_{DV}	Data Access			2.0	µs
t_{OH}	Data Hold	0			µs
t_{SC}	Data In Setup (CMP instruction)	0			µs
t_{HC}	Data In Hold (CMP instruction)	0.2			µs
t_{CHP}	CLK Pulse Width (High in Programming)	3.0			ms
t_{DS}	Data in Setup	0.2			µs
t_{DH}	Data in Hold	0			µs
t_{SPR}	PGM Setup	2.2			µs
t_{HPR}	PGM Hold	0.2			µs

16. Conditions of Dynamic Tests

The circuit has an output with open drain. An external resistor is necessary between VCC and I/O in order to load the output

Table 16-1. Conditions of Dynamic Tests.

Pulse Levels of the Input	GND to V_{CC}
Reference Levels in Input	V_{CC} x 0.3 and V_{CC} x 0.7
Reference Levels in Output	1.5V
Rising and Falling Time of Signals	5 ns

17. AC Load Circuit

Figure 17-1. AC Load Circuit
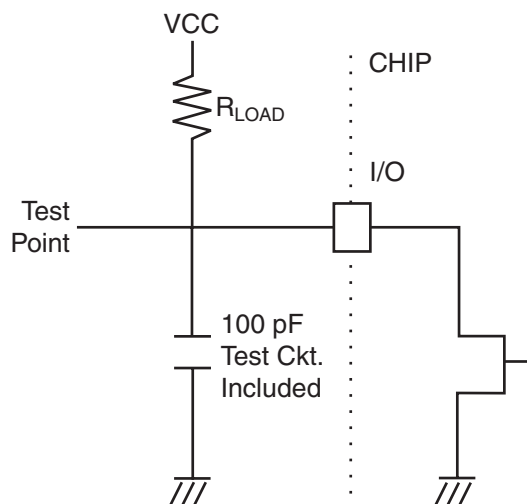
18. Timing Diagrams

18.1 Reset

Figure 18-1. Reset
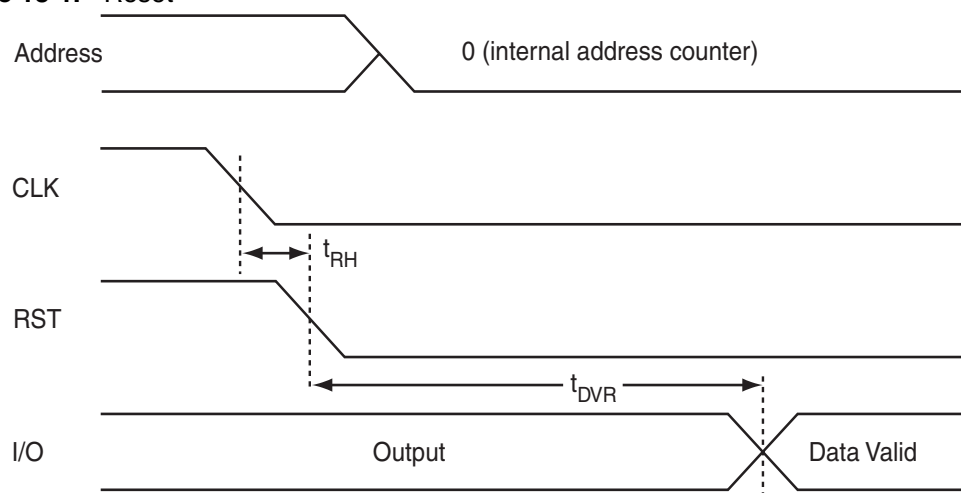
Note: CLK should be low on the falling edges of RST. CLK may remain low while RST is pulsed.

18.2 Read

Figure 18-2. Read
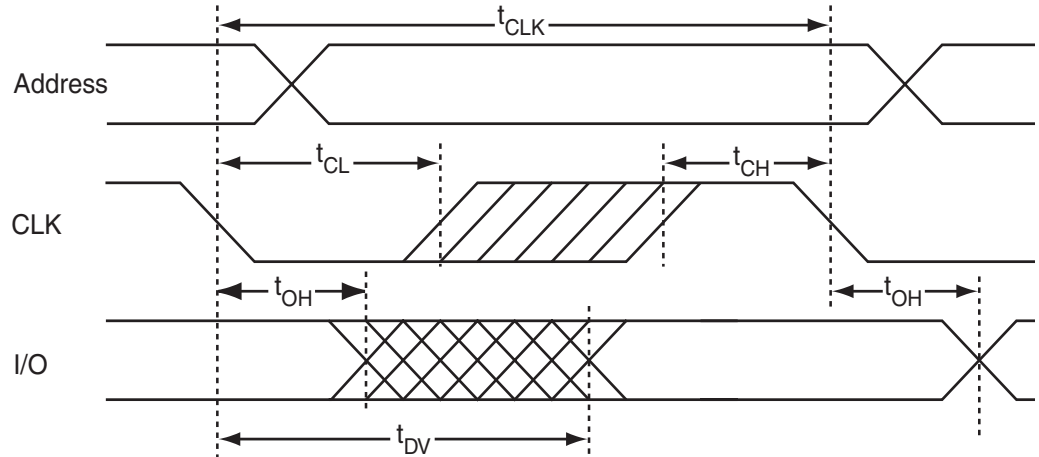
Note: PGM and RST must both be low during a read cycle. I/O should not be driven (except by the external pullup resistor).

18.3 Erase/Write

Figure 18-3. Erase/Write
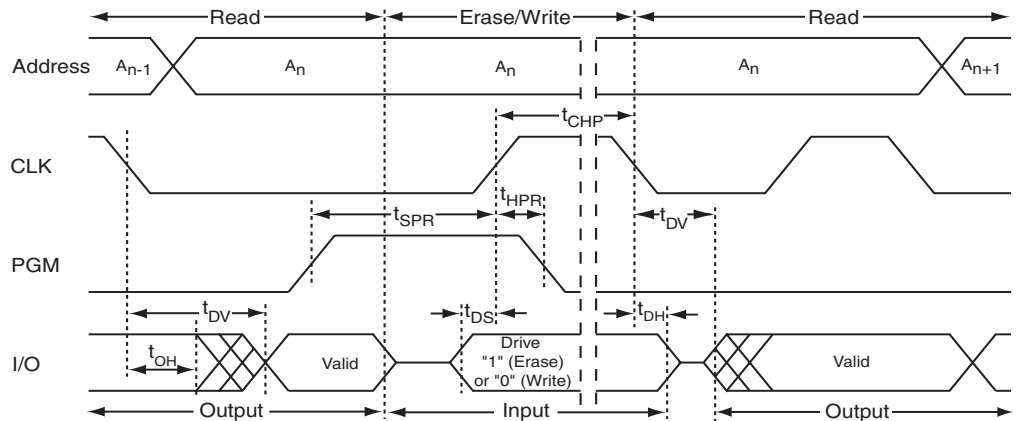
Notes: 1. During any Erase or Write operation, PGM must fall before the falling edge of CLK at the end of t_{CHP} (recommend a minimum setup of 1 µsec).

   2. After the rising edge of PGM to initiate the Erase/Write operation, delay at least t_{DV} (2 µsec) before driving data on the I/O contact.

18.4 Compare

Figure 18-4. Compare
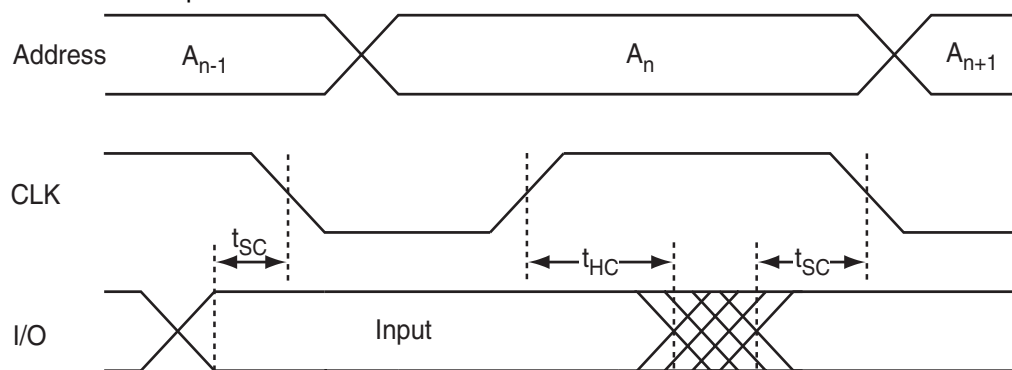
Note: Input Data is latched on the rising edge of CLK. Comparison occurs on the next falling edge of CLK. The address counter is incremented on the falling edge of CLK. During a compare operation of the first bit following a read (i.e., the first bit of the SC or erase keys), data driven to the I/O may be delayed by t_{DV} after the falling edge of CLK.

18.5 Security Code Validation

Figure 18-5. Security Code Validation
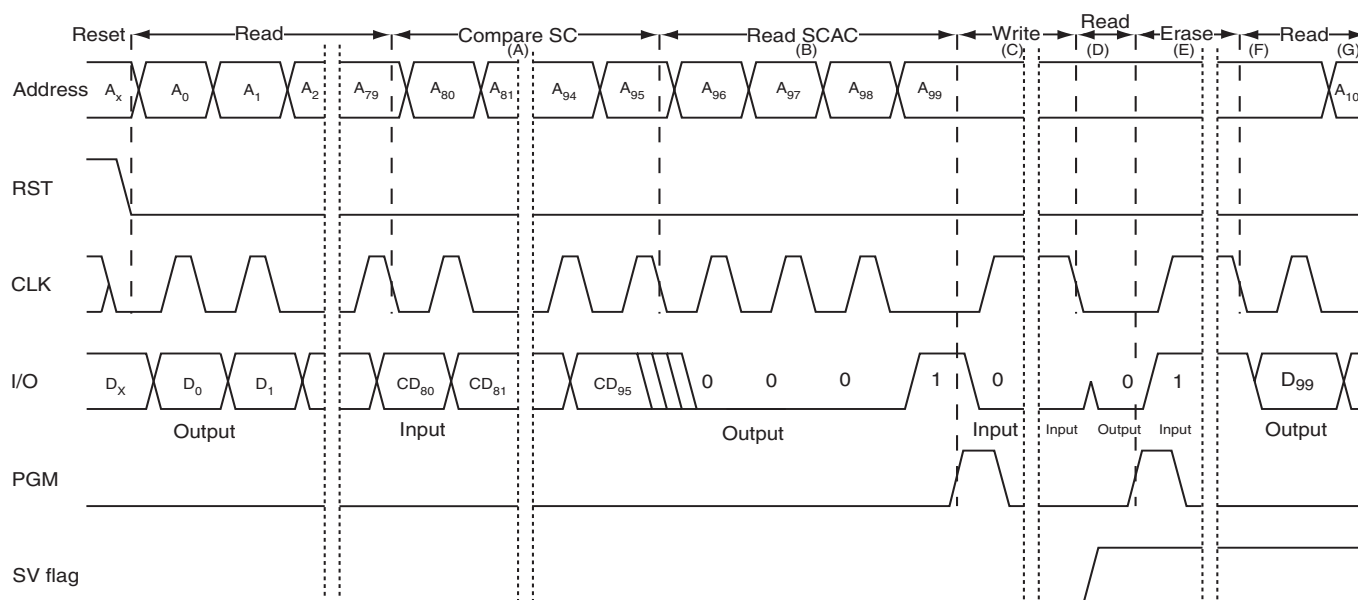
Notes: 1. A_n = Address, D_n = Read data (output), CD_n = Compare data (input

2. Security Level 2 (issuer fuse blown).

A = Compare sequence of the security code.
B = This diagram shows an example in which the first three bits of the Security Code Attempts Counter (96–98) are previously set to "0". Bit 99 in this example is a "1", so the write/erase sequence is begun with that bit.
C = Write operation of a "0" over the existing "1".
D = The AT88SC102 will output a "0" following the write operation. If the comparison is successful, the SV flag is set on the falling edge of CLK and the SCAC zone can be erased.
E = Erase operation.
F = The AT88SC102 will output a "1" following the erase operation if the security code verification is successful. If invalid, the

device will output a "0".

G = On the falling edge of CLK, the address is incremented and the state of the next bit is driven on the I/O pin.

18.6 Erase Operation

Figure 18-6. Erase Operation Application Zone 1 (AZ1)
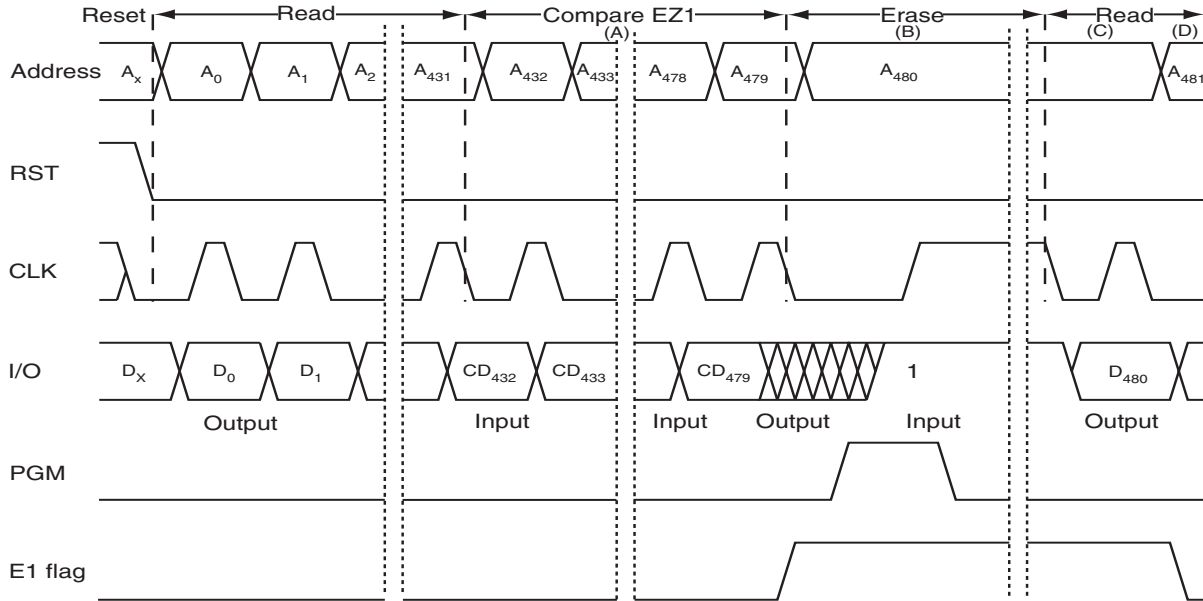
Notes: 1. A_n = Internal Address, D_n = Read data (output), CD_n = Compare data (input).

2.   This diagram illustrates the protocol for setting the E1 flag in Security Level 2 (issuer fuse blown). Erase operations in Security Level 1 within Application Zone 1 do not require setting of the E1 flag. In Security Level 1, an erase operation on any bit in Application Zone 1 will erase the entire 16-bit word containing the bit.

A = Compare sequence of EZ1. If the comparison is valid, the EZ1 flag is set to "1", enabling erasure of AZ1.
B = If E1 is set to "1", an erase operation on Bit 736 will erase Bits 176–687 (AZ1) (Security Level 1).
C = After the falling edge of CLK, the device will drive the I/O contact to the logic state of the existing data in Bit 736. The state of this bit is not affected by the AZ1 erase operation.
D = After the falling edge of CLK, the address is incremented and the state of the next bit is driven on the I/O contact.

Figure 18-7. Erase Operation Application Zone 2 (AZ2), EC2 Function Disabled
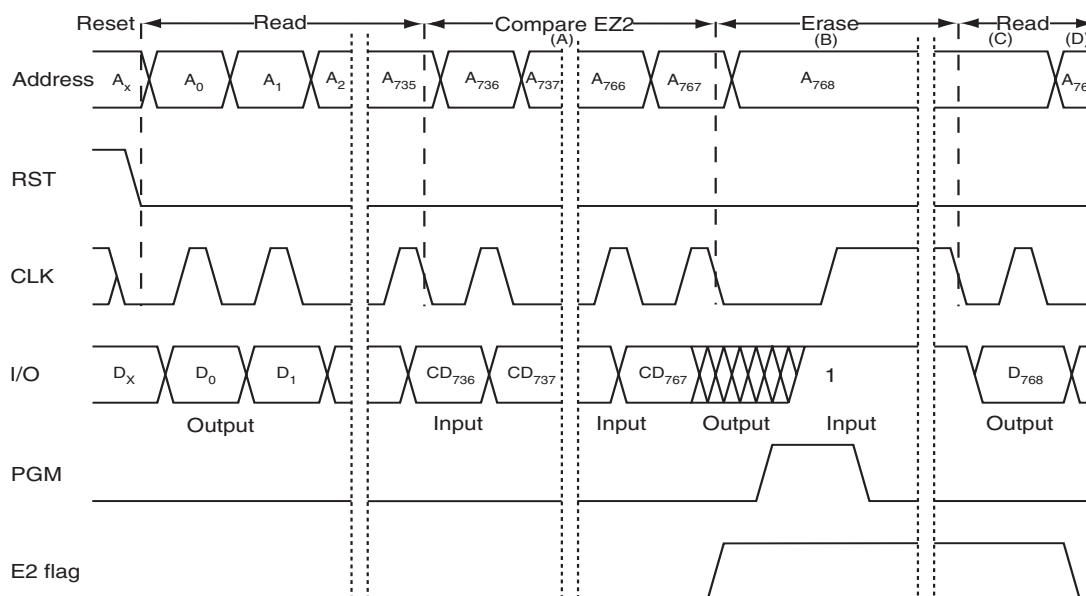
Notes: 1. A_n = Internal Address, D_n = Read data (output), CD_n = Compare data (input).

2. This diagram illustrates the protocol for setting the E2 flag in Security Level 2 (issuer fuse blown). Erase operations in Security Level 1 within Application Zone 2 do not require setting of the E2 flag. In Security Level 1, an erase operation on any bit in Application Zone 2 will erase the entire 16-bit word containing the bit.

3. EC2EN Fuse - "0" (disabled).

A = Compare sequence of EZ2. If the comparison is valid, the EZ2 flag is set to "1", enabling erasure of AZ2.
B = If E2 is set to "1", an erase operation on Bit 1280 will erase Bits 736–1247 (AZ2) (Security Level 1).
C = After the falling edge of CLK, the device will drive the I/O contact to the logic state of the existing data in Bit 1280. The state of this bit is not affected by the AZ2 erase operation.
D = After the falling edge of CLK, the address is incremented and the state of the next bit is driven on the I/O contact.

Figure 18-8. Erase Operation Application Zone 2 (AZ2) EC2 Function Enabled
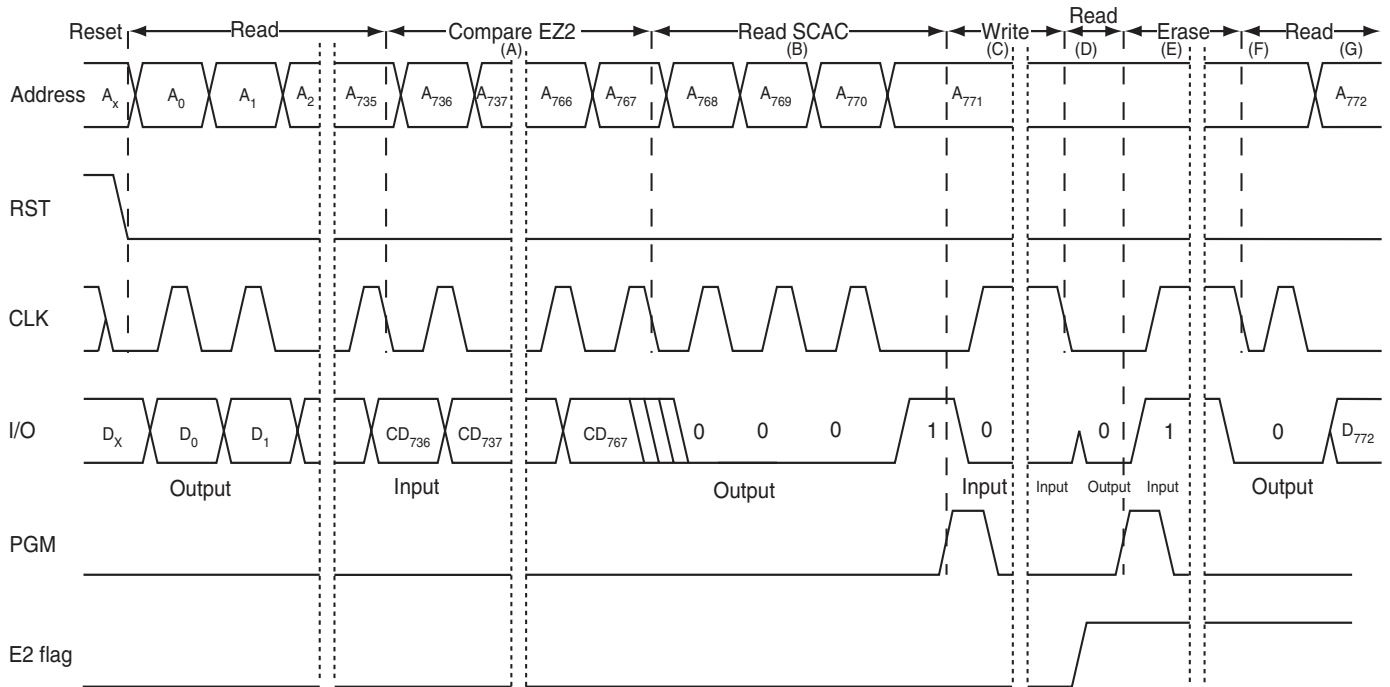
Notes: 1. A$_n$ = Internal Address, D$_n$ = Read data (output), CD$_n$ = Compare data (input).

2. EC2EN fuse = 1 (enabled)

3. Security Level 2 (issuer fuse blown)

A = Compare sequence of the Application Zone 2 Erase Key (EZ2).
B = This diagram shows an example in which the first three bits of the EC2 Erase Counter (bits 1280 – 1282) are previously set to "0". The write/erase operation should be performed on the first bit in EC2 which is found to be a "1". Bit 1283 in this example is a "1", so the write/erase sequence is begun with that bit.
C = Write operation of a "0" over the existing "1".
D = The AT88SC102 will output a "0" following the write operation. If the comparison is successful, the E2 flag is set and the AZ2 zone can be erased.
E = Erase operation.
F = The AT88SC102 will output a "0" following the erase operation regardless of the success of the compare operation.
G = On the falling edge of CLK, the address is incremented and the state of the next bit is driven on the I/O pin.

19. Ordering Information

Ordering Code[1]	Package[2]	Voltage Range	Temperature Range
AT88SC102–09ET–xx–2.7 AT88SC102–09PT–xx–2.7	M2–E Module M2–P Module	2.7V to 3.3V	Commercial (0°C to 70°C)
AT88SC102–09ET–xx AT88SC102–09PT–xx	M2–E Module M2–P Module	4.5V to 5.5V	Commercial (0°C to 70°C)

Package Type[1]	Description
M2–E Module	M2 ISO 7816 Smart Card Module
M2–P Module	M4 ISO 7816 Smart Card Module with Atmel Logo

Notes: 1. "xx" must be replaced by a security code. Contact an Atmel Sales Office for the security code.

2. Formal drawings may be obtained from an Atmel Sales Office.

20. Smart Card Modules

M2 - E Module Ordering Code: 09ET
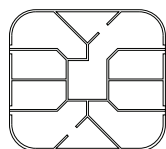
Module Size: **M2**
Dimension*: 12.6 x 11.4 [mm]
Glob Top: Round - ∅ 8.0 [mm]
Thickness: 0.58 [mm]
Pitch: 14.25 mm

M2 - P Module Ordering Code: 09PT - 00
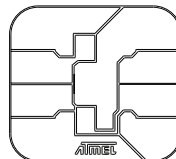
Module Size: **M2**
Dimension*: 12.6 x 11.4 [mm]
Glob Top: Square - 8.8 x 8.8 [mm]
Thickness: 0.58 [mm]
Pitch: 14.25 mm

Note: The module dimensions listed refer to the dimensions of the exposed metal contact area.
The actual dimensions of the module after excise or punching from the carrier tape are generally 0.4 mm greater in both directions (i.e. a punched M2 module will yield 13.0 x 11.8 mm).

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